Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/652,496	QHASHI ET AL.
Examiner	Art Unit
Chau Nguyen	2176

	SEARCHED					
Class	Subclass	Date	Examiner			
715	517	1/27/2006	CN			
715	520	1/27/2006	CN			
715	507	1/27/2006	CN			
715	505	1/27/2006	CN			
715	908	1/27/2006	CN			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u></u>			

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
East Reports	01/26/2006	CN
	1/27/2006	CN
	1/30/2006	CN
NPL Search on IEEE Database	1/30/2006	CN
Updated Search on East Reports	7/13/2006	CN